Preparation and Properties of MCT Ceramics for RF and THz Applications

Zhaoxian Xiong*, Zhangzhao Weng*, Jinbao Huang*, Bin Yang[#], R. Donnan[#], Haixue Yan and M.J. Reece

*Department of Materials Sciece and Engineering, Xiamen University, Xiamen 361005, China

#School of Electronic Engineering, Queen Mary University of London, London E14NS, UK

School of Engineering and Material Sciences, Queen Mary University of London, London E1 4NS, UK

*Email: zxxiong@xmu.edu.cn

Abstract — Dielectric ceramics of 0.95MgTiO₃-0.05CaTiO₃ were prepared via a solid-state reaction method. It is evident that high permittivity and low loss are correlated to high density and high purity in the THz frequency domain. Best dielectric properties were obtained for samples sintered at 1260 °C, which is attributable to their high density and high purity. However, the dielectric properties of the ceramics deteriorated when sintered above 1260 °C, which is attributed to the significantly increased content of second phase produced by 'over' sintering.

Index Terms — Dielectric ceramics, THz application, resonators, filters.

I. INTRODUCTION

In the past ten years, Terahertz (THz) technology has demonstrated extraordinary prospects due to its attractive applications in material, chemical, communication and life ciences [1-5]. Portable, low loss and light weighted THz devices are developed, for example sensors [6], resonators [7] and filters [8], to accelerate applications of THz technologies. However, the lack of advanced materials in the THz band is a major limited factor. Although obvious progress has been achived in the reliable measurement systems to test dielectric properties of materials in the THz band [9,10], systematic study on the materials with suitble dielectric properties was rarely reported. MgTiO₃, chemically a rhombohedral structure with space group R3c [11], is a popular microwave material which displays a relatively low permittivity ($\varepsilon_r=17$), high quality factor (Qf=160,000 at 7GHz) and negative temperature coefficient of resonant frequency (T =50 ppm/ °C) [12]. Beside a high permittivity and quality factor, a near-zero temperature coefficient of resonant frequency is also demanded for commercial applications. It is found that with a small addition of 5mol% CaTiO₃ (orthorhombic structure with space group Pbnm) to the samples produces improved permittivity (21), quality factor (Qf=56,000 at 7GHz) and near zero T f [12]. It is reported that MgTiO₃ and CaTiO₃ do not react into solid solutions but separate phases due to the different crystal structures [13]. In this paper, 0.95MgTiO₃-0.05CaTiO₃ ceramics, i.e., MCT, were prepared under different sintering conditions. The effects of density, phase purity and microstructure on the dielectric properties of the samples were investigated in the THz spectral domain.

II. EXPERIMENTAL PROCEDURES

Ceramics of $0.95 Mg TiO_3$ – $0.05 Ca TiO_3$ were prepared via a conventional solid-state reaction route, with chemical reagents of MgO (CP, 99%), CaCO₃ (CP, 99%) and TiO₂ (CP, 99%). The reagents were firstly weighed based on the stoichiometry of $0.95 Mg TiO_3$ – $0.05 Ca TiO_3$. The mixed powder was then calcined at $1150~^{\circ}C$ for 2h with 1wt% of ZnO added as a sintering aid. Green bodies were pressed and sintered at different temperatures, $1240~^{\circ}C$, $1260~^{\circ}C$, $1280~^{\circ}C$ and $1300~^{\circ}C$ for 3h in air, respectively.

The crystal structures of the samples were identified with X-ray diffraction (XRD) using CuK_{α} radiation (X'pert PRO, Panalytical, Holand). The microstructure of the specimens was observed by a scanning electron microscope (SEM, TM-3000, Hitachi, Japan). Element analysis was carried out with Energy-Dispersive X-ray spectroscopy (EDX, Oxford instrument). Densities were obtained using the Archimedes' method. Microwave dielectric properties of the ceramics, including ϵ , Qf and τ , were measured with the parallel plate resonator method connected with a vector network analyzer (VNA) at 8.2GHz. The THz dielectric behavior of the samples between 0.22THz and 0.32THz were measured using a VNA2-driven quasi-optical transmission meter [14].

III. RESULTS AND DISCUSSION

The density of ceramics sintered at 1240 °C, 1260 °C, 1280 °C and 1300 °C were determined to be 3.778g/cm³, 3.790g/cm³, 3.790g/cm³ and 3.790g/cm³, respectively. The apparent density increased with increasing sintering temperature and a near constant density was achieved for samples sintered above 1260 °C. The XRD patterns of dense ceramics sintered at 1260 °C, 1280 °C and 1300 °C are shown in Fig. 1. The samples are multi-phase, with a main crystal phase of MgTiO₃ (JCPDS♯79-0831), and minor ones of CaTiO₃ (JCPDS♯22-0153) and MgTi₂O₅ (JCPDS♯76- 2673). In Fig. 1, MgTi₂O₅ is indexed in the XRD for 1300 °C, MgTiO₃ is indexed for 1280 °C and CaTiO₃ is indexed for 1260 °C. The formation of the impurity phase MgTi₂O₅ is

possibly resulted from the decomposition of MgTiO $_3$ [15]. With increasing sintering temperature, MgO maybe partially dissolved in the near region of grain boundary [15]. Therefore, the XRD peak intensity of MgTi $_2$ O $_5$ increased with increasing sintering temperature. It is reported that MgTi $_2$ O $_5$ could not be fully eliminated when ceramics were prepared using conventional sintering [16]. Here, the amount of ZnO and MgO is too small to be detected by XRD.

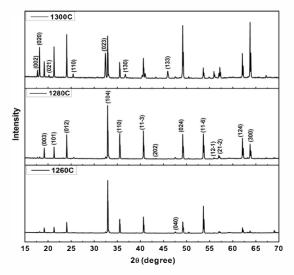


Fig. 1 XRD patterns of ceramics sintered at 1260 $^{\circ}$ C, 1280 $^{\circ}$ C and 1300 $^{\circ}$ C for 3h. Here, MgTi₂O₅ is indexed for 1300 $^{\circ}$ C, MgTiO₃ is for 1280 $^{\circ}$ C, and CaTiO₃ is only for 1260 $^{\circ}$ C.

Three different shapes of grains were observed in the ceramics sintered from 1260 °C to 1300 °C for 3h. An SEM image in addition to EDX analysis, of the ceramic sintered at 1280 °C is demonstrated in Fig. 2. According to the semi-quantitative molar ratio of Mg/Ti and Ca/Ti, the big block-shaped grains(1) were identified as MgTiO₃ due to a Mg/Ti ratio (0.97) of about 1:1. The small square block-shape grains(2) were identified as CaTiO₃ due to a Ca/Ti ratio (0.96) of about 1:1. Moreover, the small bar-shaped grains(3) were identified as a MgTi₂O₅ due to Mg/Ti ratio (0.52) of about 1:2.

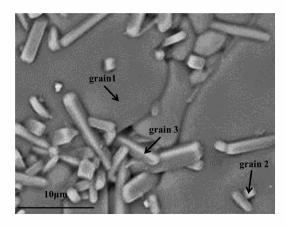


Fig. 2 SEM image of ceramic sintered at 1280 °C for 3h.

The microwave dielectric properties at 8.2GHz for ceramics sintered at different temperatures are revealed in Fig. 3. The improvement of microwave dielectric properties for samples sintered from 1240 °C to 1260 °C for 3h is attributed to the increase of the density. The maximum value of Qf=91,238GHz (at 8.2GHz) and ϵ_r =20.5 were obtained for the ceramic sintered at 1260 °C. The grain size increases with increasing sintering temperature so that the total area of the grain boundary is reduced, leading to an increase of the quality factor. However, the permittivity and Qf for samples sintered above 1260 °C both decreased. The reason for this is probably due to the increasing second phase content, as identified by XRD and SEM analysis, rather than agrain size effect in the dense samples. The sample sintered at 1240 °C was eliminated from the THz investigation because of its low density and low permittivity. According to the algorithm in the work of Yang et al. [9], dielectric properties (permittivity and loss tangent) can be obtained through complex transmission spectra of ceramics measured over abroad band frequency domain, i.e. 0.22THz to 0.32THz. The permittivity of ceramics sintered at 1260 °C, 1280 °C and 1300 °C for 3h were around 18, exhibiting minimal dispersion. The dielectric losses of the samples varied significantly from 0.0019 (sintered at 1260 °C) to 0.0072 (sintered at 1300 °C) at 0.22THz as displayed in Fig. 4. This indicates that the MgTi₂O₅ second phase had a obvious influence on the increase of loss not only in the microwave frequency domain [17] but also in the THz frequency domain (Fig. 4).

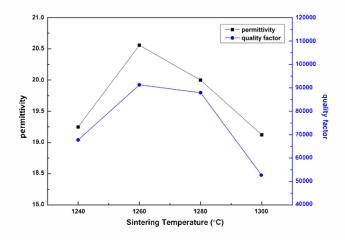
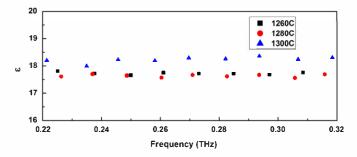


Fig. 3 Dielectric properties at 8.2GHz of ceramics sintered at 1240 $^{\circ}$ C, 1260 $^{\circ}$ C, 1280 $^{\circ}$ C and 1300 $^{\circ}$ C for 3h.



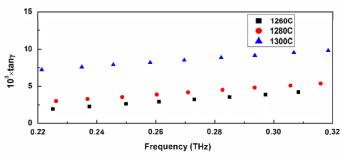


Fig. 4 Calculated permittivity (top) and loss tangent (bottom) of ceramics sintered at 1260 $^{\circ}$ C, 1280 $^{\circ}$ C and 1300 $^{\circ}$ C for 3h in the frequency range 0.22THz to 0.32THz.

IV. CONCLUSION

Dielectric ceramics of $0.95 MgTiO_3$ – $0.05 CaTiO_3$ were prepared via a solid-state reaction method. Best dielectric properties were achived for samples sintered at 1260 °C for 3h, which is attributable to their high density and high purity. However, the dielectric properties of the samples deteriorated when sintered above 1260 °C. This is attributed to the significantly increased content of second phase due to 'over' sintering of samples. It is evident that high permittivity and low loss are correlated to high density and high purity in the THz frequency domain.

ACKNOWLEDGEMENT

The authors would like to thank the Engineering and Physical Sciences Research Council (EPSRC) of UK for financial support under Grant EP/I014845, and, Fujian Provincial Department of Science and Technology of China for financial support under Grant No. 2013H6020.

REFERENCES

- [1] B. Ferguson, X.C. Zhang, "Materials for Terahertz Science and Technology," *Nat. Mater.*, vol.1, pp.26-33, 2002.
- [2] Al McIntosh, B. Yang, S.M. Goldup, M. Watkinson, R.S. Donnan, "Terahertz Spectroscopy: a Powerful New Tool for the Chemical Sciences?", *Chem. Soc. Rev.*, vol.41, pp. 2072–2082, 2012
- [3] J.H. Son, "Terahertz electromagnetic interactions with biological matter and their applications," J. Appl. Phys., vol.105, pp:102033, 2009.

- [4] P.Weightman, "Prospects for the study of biological systems with high power sources of terahertz radiation," *Phys. Biol.*, vol. 9, pp:053001, 2012.
- [5] S. Koenig, D. Lopez-Diaz, J. Antes, F. Boes, R. Henneberger, A. Leuther, et al, "Wireless sub-THz communication system with high data rate," *Nat. Photonics*, vol. 7, pp: 977–981, 2013.
- [6] M. Nagel, M. Först, H. Kurz, "THz biosensing devices: fundamentals and technology," J. Phys. Condens. Matter., vol.18, pp: S601, 2006.
- [7] I. Al-Naib, C. Jansen, M. Koch, "Thin-film sensing with planar asymmetric metamaterial resonators," *Appl. Phys. Lett.*, vol. 93, pp. 083507, 2008.
- [8] Y. Zhu, S.Vegesna, V. Kuryatkov, M. Holtz, M. Saed, A.A. Bernussi, "Terahertz bandpass filters using double-stacked metamaterial layers," Opt. Lett., vol. 37, pp:296–298, 2012.
- [9] B. Yang, R.J. Wylde, D.H. Martin, P. Goy, R.S. Donnan, S. Caroopen, "Determination of the gyrotropic characteristics of hexaferrite ceramics from 75 to 600GHz," *IEEE Trans. Microwave Theory Tech.*, vol.58, pp:3587–3597, 2010.
- [10] A. Tomasino, A. Parisi, S. Stivala, P. Livreri, A. Cino, A. Busacca, et al., "Wide band THz time domain spectroscopy based on optical rectification and electro-optic sampling," *Sci. Rep.*, pp:3, 2013.
- [11] B.A. Wechsler, R. VonDreele, "Structure refinements of Mg2TiO4, MgTiO3 and MgTi2O5 by time-of-flight neutron powder diffraction," *Acta. Crystallogr., Sect B: Struct. Sci.*, vol.45, pp:542–549, 1989.
- [12] V. Ferreira, F. Azough, R. Freer, J. Baptista, "The effect of Cr and La on MgTiO3 and MgTiO3—CaTiO3 microwave dielectric ceramics", J. Mater. Res.,; vol.12, pp:3293–3299, 1997.
- [13] Y.C. Liou, W.C. Tsai, S.L.Yang, "Synthesis of 0.95MgTiO3– 0.05CaTiO3 ceramics by reaction-sintering," The proceedings of the 16th international conference on composite materials.
- [14] Y. Wang, B. Yang, Y. Tian, R.S. Donnan, M.J. Lancaster, "Micromachined thick mesh filters for millimeter-wave and terahertz applications", *IEEE Trans. Terahertz Sci. Tech.*, vol.4, pp:247–253, 2014.
- [15] H.K. Shin, H. Shin, S.Y. Cho, K.S. Hong, "Phase evolution and dielectric properties of MgTiO3–CaTiO3 - based ceramic sintered with lithium borosilicate glass for application to low temperature co - fired ceramics", *J. Am. Ceram. Soc.*, vol.88, pp:2461–2465, 2005.
- [16] X. Zhou, Y. Yuan, L. Xiang, Y. Huang, "Synthesis of MgTiO3 by solid state reaction and characteristics with addition", J. Mater. Sci., vol.42, pp:6628–6632, 2007.
- [17] C.L. Huang, C.L. Pan, S.J. Shium, "Liquid phase sintering of MgTiO3–CaTiO3 microwave dielectric ceramics", *Mater. Chem. Phys.*, vol.78, pp:111–115, 2003.